

LArRI: a new setup for Liquid Argon Refractive Index measurement



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WhyLArRI?

Liquid Argon is one of the most widely used scintillators in particle detection, due to its low cost, high availability and excellent scintillation properties. Xenon-doping of the liquid Ar has been proven to increase the uniformity and amount of collected light, by increasing the optical scattering length. Xenon-doped LAr has a peak scintillation emission at 175 nm.

It is crucial to measure the optical properties of liquid argon

Main goal: Direct measurement of the refractive index of liquid Argon at wavelengths close to 175 nm.

Secondary goals:

•Measurement at various wavelengths (dispersion relation) oMeasurement of the attenuation length •Optical measurements with other liquefied noble gases

Project aimed at the development of optical systems, in particular lenses, for Xedoped LAr imaging

Measurement strategy

The key idea is to measure the refractive index of liquid Argon by comparing the diffraction patterns produced using a diffraction grating when the light propagates in argon and in vacuum.

When the grating is immersed in liquid Argon, the position of the diffraction peaks depends on $\lambda_L = \lambda_o / n$. Where λ_L is the wavelength in liquid, λ_o in vacuum and n is the liquid Ar refractive index.

Max in vacuum: $d \sin \theta_0 = \lambda_0$ Max in LAr: $d \sin \theta_L = \lambda_L$

We need coherent and monochromatic light





Conceptual scheme of the LArRI setup

Light

The core of the setup is a cylindrical chamber, that can be both evacuated and filled with liquid argon. The chamber is contained in a cryostat, to thermalize the system.

Warm part:

Light source: low pressure mercury lamp with emission peaks at 184.9 nm and 253.7nm

Optical setup: produces a collimated beam and a MgF₂ prism is used to select a specific



The light, coherent and monochromatic, comes from outside the cryostat, entering from above.

The diffraction pattern is recorded by scanning along the vertical axis using SiPMs mounted on a movable stand.

To compact the apparatus we do not scan on the side opposite to the grating, as is usually done, but on the lateral sides.



wavelength (184.9 mn as a proxy for LXe scintillation light). A vertical tube closed by two MgF2 viewports and in vacuum is used to send the VUV light into the cold chamber.

Cold part:

- Diffraction grating: made of aluminum deposited on a thin fused silica substrate, 720 nm pitch.
- Moving system: a motor by VacuumFab capable to operate both in vacuum and immersed into cryogenic liquids is used to lift a support housing the light detectors.
- Light detectors: 5 Hamamatsu (S13370-3075CN) UV-sensitive SiPMs (3x3 mm²), four symmetrically mounted on the moving support, one at the center.

A zoom on the optical system and alignment procedure



All the optical mounting is in air with a roughly 50% light loss at 185 nm.



After the alignment the laser can be removed and the 185 nm line is aligned with the system in the chamber.

The optical assembly is mounted on a breadboard, placed on top of the cryostat. An hole on the breadboard, in correspondence of the final mirror, allows the beam to reach the entrance viewport, go through the vacuum tube and enter into the cold chamber passing through a second viewport.

Due to the limited intensity of the 185 nm the light into the cryostat line it is not possible to align the beam directly. So we have developed a two-step procedure:

1. Align the 185 nm to a 403 nm laser, using a CCD placed on the bread board;

2. Remove the CCD and align the laser with the central SiPM, tuning the orientation of the mirrors.

Electronics and DAQ

Two custom made front end boards, placed outside the cryostat at room temperature, route the bias voltage to the SiPMs and integrate their current signals, with a τ 100 ms)

For more details see M. Cariello's poster #185 - "A Wide Dynamics Range Front-End Electronics for SiPMs using High-Speed Operational and Integration Amplifiers"

Signals are then acquired with a Teledyne Lecroy scope in 100 ms long windows, at typically rates of 2-10 Hz.

The average value of each acquired window represents a luminosity sample.

uminosity [a.u.] During a scan from top to bottom, the 4 SiPMs intercept the interference peaks: first the less intense M2, then the M1 with greater intensity.





Analysis and preliminary results

The positions of the maxima acquired in two scans, one with the chamber under vacuum and cold and the other with the chamber filled with cryogenic liquid,

To check the consistency of our method we compare data acquired in vacuum but from two different wavelengths. The pattern will





Then by knowing the motor position at the beginning and at the end of a scan we can reconstruct where every SiPM has intercepted the diffraction maxima.



are simultaneously fit to measure the refractive index. The comparison between two scans, including vacuum data, reduces the systematics effects due to the geometrical non idealities of the setup.



change according to the ratio of the λ . All the analysis is done in the same way and the expected contraction factor of the pattern (n) is the ratio between the two wavelengths ($\lambda_1 = \lambda_2/n$).

